



Specification for Approval

Date: 2022/5/9





Customer: HCB2012KF-700T30 TAI-TECH P/N: **CUSTOMER P/N: DESCRIPTION:** QUANTITY: pcs **REMARK: Customer Approval Feedback** 西北臺慶科技股份有限公司

TAI-TECH Advanced Electronics Co., Ltd

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R&D Center

APPROVED	CHECKED	DRAWN
鄧福興	浦冬生	王俞琴

High Current Ferrite Chip Bead(Lead Free)

HCB2012KF-700T30

REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWI
1.0	13/06/06	變更可靠度條件	楊祥忠	羅培君	張嘉珠
2.0	14/01/24	變更電鍍錫層厚度 3.0um min.=>3.5um min.	楊祥忠	羅培君	張嘉珰
3.0	14/08/01	變更 Reflow 圖示	楊祥忠	羅培君	張嘉珰
3.1	14/08/01	修正包裝帶尺寸	楊祥忠	羅培君	張嘉珰
4.0	16/01/26	增訂可靠度 Thermal shock: (Bead) Step3:125±2℃ 30±5min	楊祥忠	詹偉特	張嘉珰
5.0	17/02/16	修訂 Recommended PC Board Pattern	楊祥忠	詹偉特	張嘉珰
6.0	6.0 20/08/01 更新 Reflow 依 IPC EDEC J-STD-020E		鄧福興	浦冬生	王俞琴
備					
館註					

TAI-TECH KBM01-220500230 P2.

High Current Ferrite Chip Bead(Lead Free)

HCB2012KF-700T30

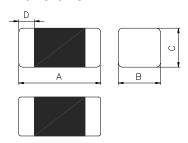
Certificate

Green Partner

1.Features

- 1. Monolithic inorganic material construction.
- 2. Closed magnetic circuit avoids crosstalk.
- 3. Suitable for reflow soldering.
- 4. Shapes and dimensions follow E.I.A. spec.
- 5. Available in various sizes.
- 6. Excellent solder ability and heat resistance.
- 7. High reliability.
- 8.100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 9. Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 10. Operating Temperature : -55~+125 $^{\circ}$ C (Including self-temperature rise)

2.Dimensions



Chip Size					
A 2.00±0.20					
В	1.25±0.20				
С	0.85±0.20				
D	0.50±0.30				

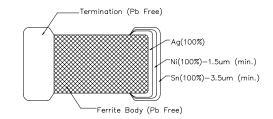
Units: mm

3.Part Numbering



D: Impedance $700=70 \Omega$ E: Packaging T=Taping and Reel, B=Bulk(Bags)

F: Rated Current 30=3000mA

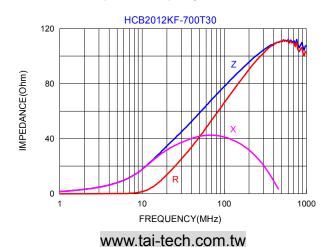


4. Specification

Tai-Tech Part Number	Impedance (Ω)	Test Frequency (Hz)	DC Resistance (Ω) max.	Rated Current (mA) max.	
HCB2012KF-700T30	70±25%	60mV/100M	0.04	3000	

- Rated current: based on temperature rise test
- In compliance with EIA 595

Impedance-Frequency Characteristics



TAI-TECH KBM01-220500230 P3.

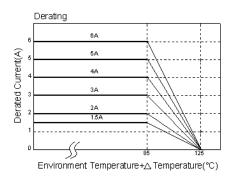
5. Reliability and Test Condition

Item			Performance				Те	st Cond	dition	
Series No.	FCB	FCM	HCB	GHB	FCA					
Operating Temperature		(la alua	-55~+125°C	:\						
		(Includ	ding self-tempera	ture rise)						
Transportation Storage Temperature			-55~+125°C (on board)			-			ons, please	see the
			(on board)			Applicati		ce		
Immedence (7)						Agilent4:				
Impedance (Z)						Agilent4				
	Refer to stand	dard electrical ch	naracteristics list			Agilent1	5192			
DC Resistance	-					Agilent 4		h.		
Rated Current							ted Curr		ements, the	re will be
Temperature Rise Test		1A ΔT 20℃Max : 1A ΔT 40℃Max	(2. Tempe		lowed DC neasured	current. by digital su	urface
Life test	Appearance:	no damage. vithin±15%of init	ial value.			times.(II Reflow F Tempera Applied of Duration Measure for 24±2 Precond	PC/JED Profiles) ture: 12 current: : 1000± d at ro hrs. itioning:	EC J-STD 5±2℃ rated curr 12hrs. om tempe	erature afte	r placing
Load Humidity			alue and shall no	t exceed the spe	ecification value	times.(IPC/JEDEC J-STD-020E Classificati Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2°C. Duration:1000hrsMin.Bead:with100%ratedci ent · Inductance: with 10% rated curre Measured at room temperature after placi for 24±2 hrs. Preconditioning: Run through IR reflow for times.(IPC/JEDEC J-STD-020E Classificati Reflow Profiles) Condition for 1 cycle Step1: -55 ±2°C 30±5 min. Step2: 125±2°C 30±5min. Number of cycles: 500 Measured at room temperature after placi for 24±2 hrs.			ratedcurr current r placing	
Thermal shock		vithin±15%of init	ial value. alue and shall no	t exceed the spe	ecification value				sification	
Vibration		within±15% of in	nitial value alue and shall nc	it exceed the spe	ecification value	times.(II Reflow F Oscillation for 20 min Equipment Total Am	PC/JED Profiles) on Freq Inutes ent : Vi plitude:	EC J-STD juency: 10 bration ch 10g 2 hours(20	ugh IR refl 0-020E Clas 0Hz ~ 2KHz ecker 0 minutes, 1	sification z ∼ 10Hz
Bending	Impedance :	: No damage. within±10% of ir ±15% of initial v	nitial value value and shall no	t exceed the spe	ecification value	following >=0805in <0805in Bending >=0805in <0805in	dimens nch(201 ch(2012 depth: nch(201 ch(2012	sions: 2mm):40x	m	
						Test co	ndition	:		
	Δημορισμος	· No damaga				Tuno	Peak Value	Normal duration	Wave form	Velocity change
Shock	Impedance :	No damage. within±10% of ir		A accepted the		Type	(g's)	(D) (ms)	TTUVE (UIII)	(Vi)ft/sec
	RDC: within	±15% of initial v	alue and shall no	t exceed the spe	ecification value	SMD	50	11	Half-sine	11.3
									Half-sine @155°C d	-
Solderability	More than 959	% of the terminal	l electrode should	d be covered with	n solder.	@235°C b. Metho ± 15 min	±5°C Te od D cat)@ 260	est time:5	+0/-0.5 seco	onds.

Item	Performance	Test Condition		
		Number of heat cycles: 1		
Resistance to Soldering	Appearance : No damage.	Temperature (s) Time ramp/immersion and emersion rate		
Heat	Impedance: within±15% of initial value RDC: within ±15% of initial value and shall not exceed the specification value	260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s		
		Depth: completely cover the termination		
Terminal strength	Appearance : No damage. Impedance : within±15% of initial value RDC : within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) Component mounted on a PCB apply a force >0805inch(2012mm):1kg <=0805inch(2012mm):0.5kg to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to shock the component being tested.		

**Derating Curve

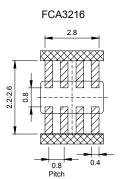
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over $85^{\circ}\mathrm{C}$, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



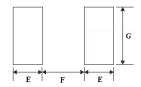
6. Soldering and Mounting

6-1. Recommended PC Board Pattern

			Pattern ow Sold					
Series	Туре	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	F(mm)	G(mm)
FCB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	0.50	0.40	0.60
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	0.80	0.85	0.95
HCB	2012	<mark>2.0±0.20</mark>	<mark>1.25±0.20</mark>	0.85±0.20	0.50±0.30	1.05	1.00	1.45
GHB	2012	2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30	1.05	1.00	1.45
FCI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	1.05	2.20	1.80
FHI	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	1.05	2.20	2.70
FCH	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	1.05	3.30	1.80
HCI	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	1.05	3.30	3.40



Land
Solder Resist



PC board should be designed so that products can prevent damage from mechanical stress when warping the board.

6-2. Soldering

Mildly activated rosin fluxes are preferred. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

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6-2.1 IR Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Figure 2.)

- Preheat circuit and products to 150℃
- Never contact the ceramic with the iron tip

• 1.0mm tip diameter (max)

- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- Limit soldering time to 4~5sec.

Fig.1 IR Soldering Reflow

• 350°C tip temperature (max)

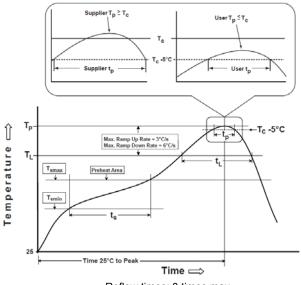
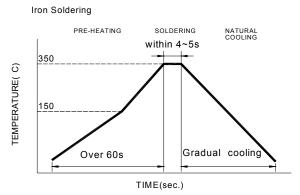


Fig.2 Iron soldering temperature profiles



Iron Soldering times: 1 times max

Reflow times: 3 times max

Table (1.1): Reflow Profiles

Profile Type:	Pb-Free Assembly
Preheat -Temperature Min(T _{smin}) -Temperature Max(T _{smax}) -Time(t _s)from(T _{smin} to T _{smax})	150°C 200°C 60-120seconds
Ramp-up rate(T_L to T_p)	3°C/second max.
$\label{eq:Liquidus} \begin{array}{c} \text{Liquidus temperature}(T_L) \\ \text{Time}(t_L) \text{maintained above } T_L \end{array}$	217℃ 60-150 seconds
Classification temperature(T _c)	See Table (1.2)
$\label{eq:total_final} \mbox{Time}(t_p) \mbox{ at Tc-} \mbox{ 5^{\circ}\!$	< 30 seconds
Ramp-down rate(T _p to T _L)	6°C /second max.
Time 25℃ to peak temperature	8 minutes max.

Tp: maximum peak package body temperature, Tc: the classification temperature.

For user (customer) ${\bf Tp}$ should be equal to or less than ${\bf Tc.}$

Table (1.2) Package Thickness/Volume and Classification Temperature (Tc)

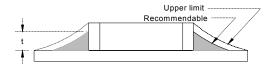
	Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
	<1.6mm	260°C	260°C	260°C
PB-Free Assembly	1.6-2.5mm	260°C	250°C	245°C
	≥2.5mm	250°C	245°C	245°C

Reflow is referred to standard IPC/JEDEC J-STD-020E •

6-2.3 Solder Volume:

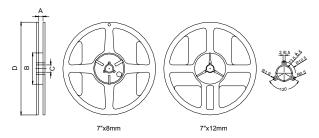
Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height



7.Packaging Information

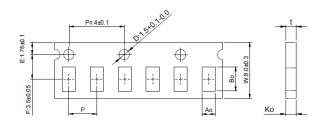
7-1. Reel Dimension



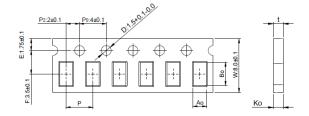
Туре	A(mm)	B(mm)	C(mm)	D(mm)	
<mark>7"x8mm</mark>	9.0±0.5	<mark>60±2</mark>	<mark>13.5±0.5</mark>	178±2	
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2	

7-2.1 Tape Dimension / 8mm

■Material of taping is paper

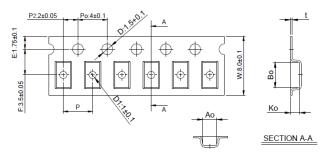


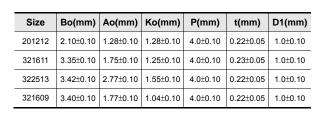
Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
100505	1.12±0.03	0.62±0.03	0.60±0.03	2.0±0.05	0.60±0.03



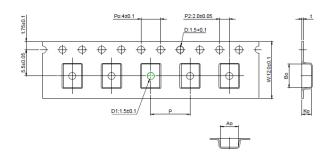
Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
160808	1.80±0.05	0.96+0.05/-0.03	0.95±0.05	4.0±0.10	0.95±0.05
<mark>201209</mark>	<mark>2.10±0.05</mark>	1.30±0.05	<mark>0.95±0.05</mark>	4.0±0.10	<mark>0.95±0.05</mark>

■Material of taping is plastic





7-2.2 Tape Dimension / 12mm



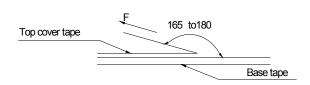
Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
451616	4.70±0.10	1.75±0.10	1.75±0.10	4.0±0.10	0.24±0.05	1.5±0.10
453215	4.70±0.10	3.45±0.10	1.60±0.10	8.0±0.10	0.24±0.05	1.5±0.10

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7-3. Packaging Quantity

Chip Size	453215	451616	322513	321611	321609	201212	<mark>201209</mark>	160808	100505
Chip / Reel	1000	2000	2500	3000	3000	2000	<mark>4000</mark>	4000	10000
Inner box	4000	8000	12500	15000	15000	10000	20000	20000	50000
Middle box	20000	40000	62500	75000	75000	50000	100000	100000	250000
Carton	40000	80000	125000	150000	150000	100000	200000	200000	500000

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

Storage Conditions(component level)

To maintain the solder ability of terminal electrodes:

- 1. TAI-TECH products meet IPC/JEDEC J-STD-020E standard-MSL, level 1.
- 3. Recommended products should be used within 12 months from the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.





Test Report

號碼(No.): ETR21C00682

日期(Date): 10-Dec-2021

頁數(Page): 1 of 15

西北臺慶科技股份有限公司 (TAI-TECH ADVANCED ELECTRONICS CO., LTD.)

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中國・江蘇省・宿遷市・泗洪縣・經濟開發區杭州路南側,建設北路東側 (THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD · ECONOMIC DEVELOPMENT ZONE · SIHONG COUNTY · SUQIANCITY · JIANGSU PROVINCE · P.R · CHINA)

以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

樣品名稱(Sample Name)

FERRITE CHIP BEAD . FERRITE CHIP INDUCTOR . ARRAY . MCF . MCM .

YMV SERIES

樣品型號(Style/Item No.)

FERRITE CHIP BEAD . FERRITE CHIP INDUCTOR . ARRAY . MCF . MCM .

YMV SERIES

收件日(Sample Receiving Date)

03-Dec-2021

測試期間(Testing Period)

03-Dec-2021 to 10-Dec-2021

測試需求(Test Requested)

依據客戶要求進行測試,測試項目請參閱測試結果表格。(Testing item(s) is/are specified by client. Please refer to result table for testing item(s).)

測試結果(Test Results)

請參閱下一頁 (Please refer to following pages.)





PIN CODE: 14A3CBB3

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Test Report

號碼(No.): ETR21C00682

日期(Date): 10-Dec-2021

頁數(Page): 2 of 15

西北臺慶科技股份有限公司 (TAI-TECH ADVANCED ELECTRONICS CO., LTD.)

臺慶精密電子 (昆山) 有限公司 (TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

慶邦電子元器件 (泗洪) 有限公司 (TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

桃園市楊梅區幼獅工業區幼四路1號 (NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN R. O. C.)

江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 (GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

中國·江蘇省·宿遷市·泗洪縣·經濟開發區杭州路南側·建設北路東側 (THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD · ECONOMIC DEVELOPMENT ZONE · SIHONG COUNTY · SUQIANCITY · JIANGSU PROVINCE · P,R · CHINA)

測試部位敘述 (Test Part Description)

No 1

整體混測 (MIXED ALL PARTS)

測試結果 (Test Results)

測試項目	測試方法	單位	MDL	結果
(Test Items)	(Method)	(Unit)		(Result)
				No.1
鎘 (Cd) (Cadmium (Cd)) (CAS No.: 7440-	參考IEC 62321-5: 2013 · 以感應耦合電漿發射光	mg/kg	2	n.d.
43-9)	譜儀分析。(With reference to IEC 62321-5:			
	2013, analysis was performed by ICP-OES.)			
鉛 (Pb) (Lead (Pb)) (CAS No.: 7439-92-1)	參考IEC 62321-5: 2013 · 以感應耦合電漿發射光	mg/kg	2	n.d.
	譜儀分析。(With reference to IEC 62321-5:			
	2013, analysis was performed by ICP-OES.)			
汞 (Hg) (Mercury (Hg)) (CAS No.: 7439-	參考IEC 62321-4: 2013+ AMD1: 2017,以感應耦	mg/kg	2	n.d.
97-6)	合電漿發射光譜儀分析。(With reference to IEC			
·	62321-4: 2013+ AMD1: 2017, analysis was			<u> </u>
	performed by ICP-OES.)			
六價鉻 Cr(VI) (Hexavalent Chromium	參考IEC 62321-7-2: 2017,以紫外光-可見光分光	mg/kg	8	n.d.
Cr(VI)) (CAS No.: 18540-29-9)	光度計分析。(With reference to IEC 62321-7-2:			
	2017, analysis was performed by UV-VIS.)			

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測試項目	測試方法	單位	MDL	結果
(Test Items)	(Method)	(Unit)		(Result)
				No.1
一溴聯苯 (Monobromobiphenyl)		mg/kg	5	n.d.
二溴聯苯 (Dibromobiphenyl)		mg/kg	5	n.d.
三溴聯苯 (Tribromobiphenyl)		mg/kg	5	n.d.
四溴聯苯 (Tetrabromobiphenyl)		mg/kg	5	n.d.
五溴聯苯 (Pentabromobiphenyl)		mg/kg	5	n.d.
六溴聯苯 (Hexabromobiphenyl)		mg/kg	5	n.d.
七溴聯苯 (Heptabromobiphenyl)		mg/kg	5	n.d.
八溴聯苯 (Octabromobiphenyl)		mg/kg	5	n.d.
九溴聯苯 (Nonabromobiphenyl)		mg/kg	5	n.d.
十溴聯苯 (Decabromobiphenyl)		mg/kg	5	n.d.
多溴聯苯總和 (Sum of PBBs)	*** *** *** *** *** *** *** *** *** **	mg/kg	-	n.d.
一溴聯苯醚 (Monobromodiphenyl ether)		mg/kg	5	n.d.
二溴聯苯醚 (Dibromodiphenyl ether)	lanalysis was performed by GC/W3.7	mg/kg	5	n.d.
三溴聯苯醚 (Tribromodiphenyl ether)		mg/kg	5	n.d.
四溴聯苯醚 (Tetrabromodiphenyl ether)		mg/kg	5	n,d.
五溴聯苯醚 (Pentabromodiphenyl ether)		mg/kg	5	n.d.
六溴聯苯醚 (Hexabromodiphenyl ether)		mg/kg	5	n.d.
七溴聯苯醚 (Heptabromodiphenyl ether)		mg/kg	5	n.d.
八溴聯苯醚 (Octabromodiphenyl ether)		mg/kg	5	n.d.
九溴聯苯醚 (Nonabromodiphenyl ether)		mg/kg	5	n.d.
十溴聯苯醚 (Decabromodiphenyl ether)		mg/kg	5	n.d.
多溴聯苯醚總和 (Sum of PBDEs)		mg/kg	-	n.d.

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測試項目	測試方法	單位	MDL	結果
(Test Items)	(Method)	(Unit)		(Result)
				No.1
鄭苯二甲酸丁苯甲酯 (BBP) (Butyl benzyl		mg/kg	50	n.d.
phthalate (BBP)) (CAS No.: 85-68-7)				
鄰苯二甲酸二丁酯 (DBP) (Dibutyl		mg/kg	50	n.d.
phthalate (DBP)) (CAS No.: 84-74-2)			÷	
鄰苯二甲酸二(2-乙基己基)酯 (DEHP) (Di-		mg/kg	50	n.d.
(2-ethylhexyl) phthalate (DEHP)) (CAS				
No.: 117-81-7)				
鄰苯二甲酸二異丁酯 (DIBP) (Diisobutyl		mg/kg	50	n.d.
phthalate (DIBP)) (CAS No.: 84-69-5)				
鄰苯二甲酸二異癸酯 (DIDP) (Diisodecyl		mg/kg	50	n.d.
phthalate (DIDP)) (CAS No.: 26761-40-	參考IEC 62321-8: 2017 · 以氣相層析儀/質譜儀分			
0, 68515-49-1)	析。(With reference to IEC 62321-8: 2017,			
鄰苯二甲酸二異壬酯 (DINP) (Diisononyl	analysis was performed by GC/MS.)	mg/kg	50	n.d.
phthalate (DINP)) (CAS No.: 28553-12-				
0, 68515-48-0)				
鄰苯二甲酸二正辛酯 (DNOP) (Di-n-octyl		mg/kg	50	n.d.
phthalate (DNOP)) (CAS No.: 117-84-0)]
鄰苯二甲酸二正戊酯 (DNPP) (Di-n-		mg/kg	50	n.d.
pentyl phthalate (DNPP)) (CAS No.:				
131-18-0)				i
鄰苯二甲酸二正己酯 (DNHP) (Di-n-hexyl		mg/kg	50	n,d.
phthalate (DNHP)) (CAS No.: 84-75-3)				

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測試項目 (Test Items)	測試方法 (Method)	單位 (Unit)	MDL	結果 (Result) No.1
六溴環十二烷及所有主要被辨別出的異構物(HBCDD) (α - HBCDD, β - HBCDD, γ - HBCDD) (Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α - HBCDD, β - HBCDD, γ - HBCDD)) (CAS No.: 25637-99-4, 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	参考IEC 62321-9: 2021・以氣相層析儀/質譜儀分析。(With reference to IEC 62321-9: 2021, analysis was performed by GC/MS.)	mg/kg	20	n.d.
氟 (F) (Fluorine (F)) (CAS No.: 14762-94-8)		mg/kg	50	n.d.
氯 (CI) (Chlorine (CI)) (CAS No.: 22537- 15-1)	参考BS EN 14582: 2016 · 以離子層析儀分析。	mg/kg	50	n.d.
溴 (Br) (Bromine (Br)) (CAS No.: 10097- 32-2)	(With reference to BS EN 14582: 2016, analysis was performed by IC.)	mg/kg	50	n.d.
碘 (I) (Iodine (I)) (CAS No.: 14362-44-8)		mg/kg	50	n.d.
全氟辛烷磺酸及其鹽類 (PFOS and its salts) (CAS No.: 1763-23-1 and its salts)	參考CEN/TS 15968: 2010 · 以液相層析串聯質譜 儀分析。(With reference to CEN/TS 15968: 2010, analysis was performed by LC/MS/MS.)	mg/kg	0.01	n.d.
全氟辛酸及其鹽類 (PFOA and its salts) (CAS No.: 335-67-1 and its salts)	參考CEN/TS 15968: 2010,以液相層析串聯質譜 儀分析。(With reference to CEN/TS 15968: 2010, analysis was performed by LC/MS/MS.)	mg/kg	0.01	n.d.

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測試項目 (Test Items)	測試方法 (Method)	單位 (Unit)	MDL	結果 (Result) No.1
聚氯乙烯 (Polyvinyl chloride) (PVC)	參考ASTM E1252: 2013,以傳立葉轉換紅外線光 譜儀及焰色法分析。(With reference to ASTM E1252: 2013, analysis was performed by FT-IR and Flame Test.)	**	-	Negative
銻 (Sb) (Antimony (Sb)) (CAS No.: 7440- 36-0)		mg/kg	2	n.d.
鈹 (Be) (Beryllium (Be)) (CAS No.: 7440- 41-7)	參考US EPA 3052: 1996,以感應耦合電漿發射光 譜儀分析。(With reference to US EPA 3052:	mg/kg	2	n.d.
砷 (As) (Arsenic (As)) (CAS No.: 7440- 38-2)	1996, analysis was performed by ICP-OES.)	mg/kg	2	n.d.

備註(Note):

- 1. mg/kg = ppm ; 0.1wt% = 1000ppm
- 2. MDL = Method Detection Limit (方法偵測極限值)
- 3. n.d. = Not Detected (未檢出): 小於MDL / Less than MDL
- 4. "-" = Not Regulated (無規格值)
- 5. **= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 全氟辛烷磺酸及其鹽類包含 (PFOS and its salts including):
 - CAS No.: 29081-56-9, 2795-39-3, 29457-72-5, 70225-14-8, 56773-42-3, 251099-16-8, 307-35-7.
- 8. 全氟辛酸及其鹽類包含 (PFOA and its salts including):
 - CAS No.: 3825-26-1, 335-95-5, 2395-00-8, 335-93-3, 335-66-0.
- 9. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量。
 The sample(s) was/were analyzed on behalf of the applicant as mixing sample in one testing. The above result(s) was/were only given as the informality value.

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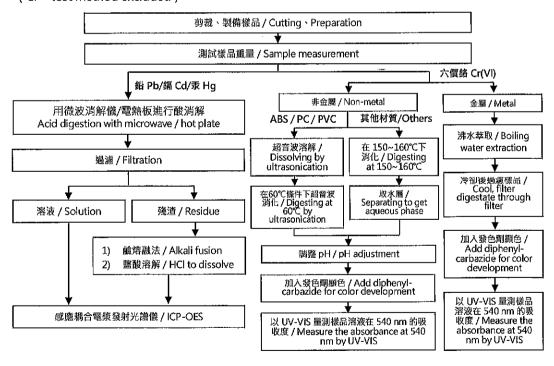
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重金屬流程圖 / Analytical flow chart of Heavy Metal

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外)

These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr^{6+} test method excluded)



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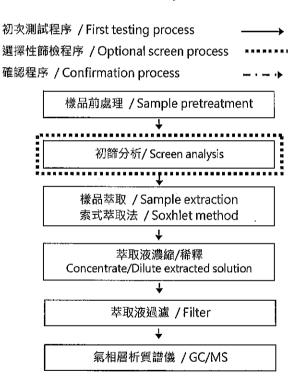
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多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBBs/PBDEs



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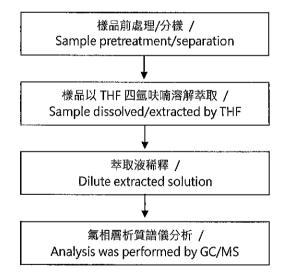
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可塑劑分析流程圖 / Analytical flow chart - Phthalate

【測試方法/Test method: IEC 62321-8】



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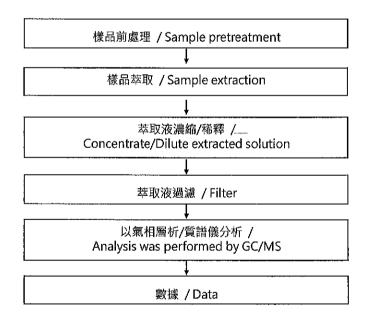
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六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD



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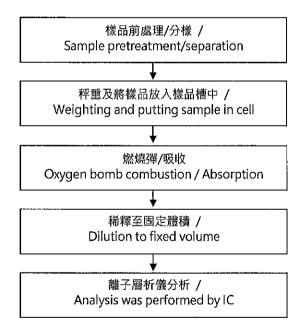
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鹵素分析流程圖 / Analytical flow chart - Halogen



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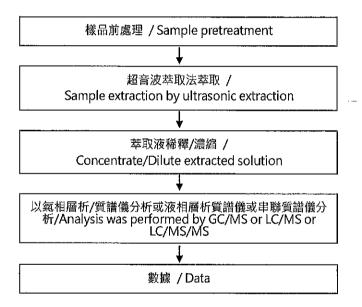
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全氟化合物(包含全氟辛酸/全氟辛烷磺酸/其相關化合物等等)分析流程圖 / Analytical flow chart – PFAS (including PFOA/PFOS/its related compound, etc.)



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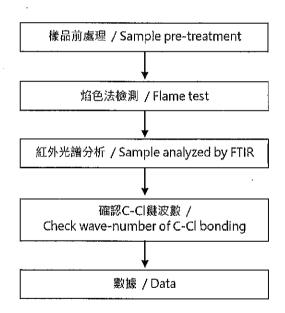
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聚氯乙烯物質判定分析流程圖 / Analysis flow chart - PVC



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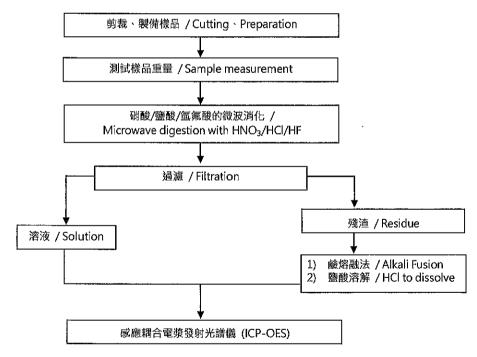
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元素(含重金屬)分析流程圖 / Analytical flow chart of Elements (Heavy metal included)

根據以下的流程圖之條件,樣品已完全溶解。

These samples were dissolved totally by pre-conditioning method according to below flow chart. 【參考方法/Reference method: US EPA 3051A、US EPA 3052】



* US EPA 3051A 方法未添加氫氟酸 / US EPA 3051A method does not add HF.

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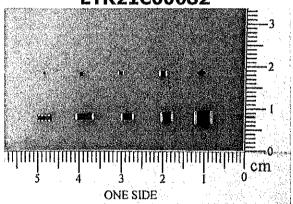
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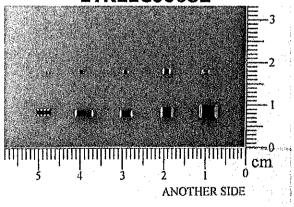
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* 照片中如有節頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)

ETR21C00682



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** 報告結尾 (End of Report) **

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